

BFX 20**450 Mc/s LOW NOISE, SMALL SIGNAL AMPLIFIER****NPN DIFFUSED SILICON PLANAR TRANSISTOR**

GENERAL DESCRIPTION—The BFX 20 is a high frequency NPN silicon PLANAR transistor specifically designed for low noise, small signal amplifiers and is particularly suitable for the UHF stages of radar and telecommunications systems. It features 16 dB of Power Gain and 5.5 dB of NF at 450 Mc/s and excellent AGC characteristics.

ABSOLUTE MAXIMUM RATINGS (Note 1)**Maximum Temperatures**

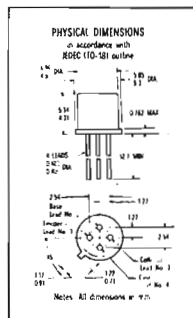
Storage Temperature	-55°C to +200°C
Operating Junction Temperature	200°C Maximum
Lead Temperature (Soldering, No Time Limit)	200°C Maximum

Maximum Power Dissipations

Total Dissipation at 25°C Case Temperature (Note 2)	0.26 W _{att}
at 25°C Ambient Temperature (Note 2)	0.175 Watt

Maximum Voltages

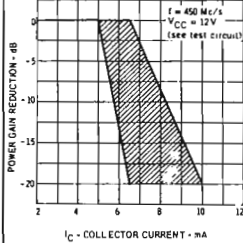
BV _{CBO}	Collector to Base Voltage	30 Volts
LV _{CEO}	Collector to Emitter Voltage (Note 3)	30 Volts
BV _{EBO}	Emitter to Base Voltage	3.0 Volts

**ELECTRICAL CHARACTERISTICS (25°C free air temperature unless otherwise noted)**

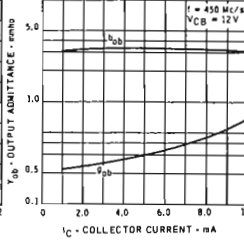
SYMBOL	CHARACTERISTIC	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS
h_{FE}	DC Pulse Current Gain (Note 4)	20	75			$I_C = 2.5 \text{ mA}$ $V_{CE} = 24 \text{ V}$
h_{FE}	DC Pulse Current Gain (Note 4)	20	70			$I_C = 2.5 \text{ mA}$ $V_{CE} = 12 \text{ V}$
$V_{BE}(\text{on})$	Base to Collector Voltage		0.9		V	$I_C = 2.5 \text{ mA}$ $V_{CE} = 24 \text{ V}$
I_{CBO}	Collector Cutoff Current		0.1	50	nA	$I_E = 0$ $V_{CB} = 10 \text{ V}$
BV _{CBO}	Collector to Base Breakdown Voltage	30			V	$I_C = 50 \mu\text{A}$ $I_E = 0$
BV _{EBO}	Emitter to Base Breakdown Voltage	3.0			V	$I_C = 0$ $I_E = 50 \mu\text{A}$
LV _{CEO}	Collector to Emitter Sustaining Voltage (Notes 3 and 4)	30			V	$I_C = 5.0 \text{ mA}$ $I_B = 0$
h_{fe}	High Frequency Current Gain ($f = 100 \text{ Mc/s}$)	4.0	5.5			$I_C = 2.5 \text{ mA}$ $V_{CE} = 12 \text{ V}$
C_{re}	Common Emitter Feedback Capacitance		0.4	0.6	pF	$I_C = 2.5 \text{ mA}$ $V_{CE} = 12 \text{ V}$
C_{re}	Common Emitter Feedback Capacitance		0.27	0.5	pF	$I_C = 2.5 \text{ mA}$ $V_{CE} = 24 \text{ V}$
PG ₁	Power Gain ($f = 450 \text{ Mc/s}$) (Note 5)	12	16		dB	$I_C = 2.5 \text{ mA}$ $V_{CC} = 12 \text{ V}$
PG ₂	Power Gain ($f = 450 \text{ Mc/s}$) (Note 5)	12	16		dB	$I_C = 2.5 \text{ mA}$ $V_{CC} = 24 \text{ V}$
AGC	Automatic Gain Control ($f = 450 \text{ Mc/s}$) (Note 5)	6.5		10	mA	I_C for which $P_G = PG_1 - 20 \text{ dB}$
NF	Noise Figure (Note 6)		5.5	7.5	dB	$I_C = 2.5 \text{ mA}$ $V_{CE} = 12 \text{ V}$
NF	Noise Figure (Note 6)		5.5	7.5	dB	$I_C = 2.5 \text{ mA}$ $V_{CE} = 24 \text{ V}$

TYPICAL ELECTRICAL CHARACTERISTICS

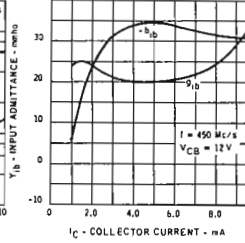
GAIN REDUCTION SPREAD VERSUS COLLECTOR CURRENT



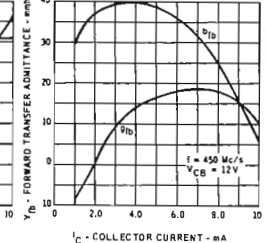
OUTPUT ADMITTANCE VERSUS COLLECTOR CURRENT INPUT SHORT CIRCUIT



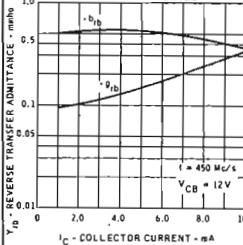
INPUT ADMITTANCE VERSUS COLLECTOR CURRENT OUTPUT SHORT CIRCUIT



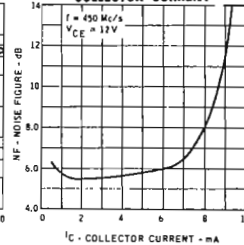
FORWARD TRANSFER ADMITTANCE VERSUS COLLECTOR CURRENT OUTPUT SHORT CIRCUIT



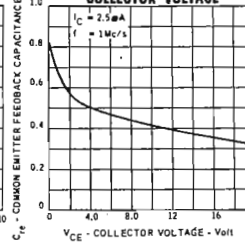
REVERSE TRANSFER ADMITTANCE VERSUS COLLECTOR CURRENT INPUT SHORT CIRCUIT



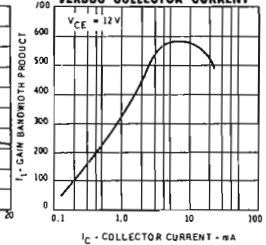
NOISE FIGURE VERSUS COLLECTOR CURRENT



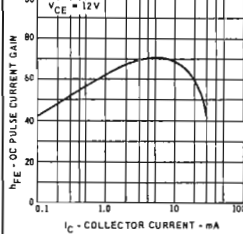
COMMON EMITTER FEED-BACK CAPACITANCE VERSUS COLLECTOR VOLTAGE



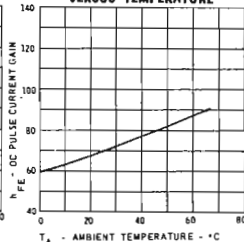
GAIN BANDWIDTH PRODUCT VERSUS COLLECTOR CURRENT



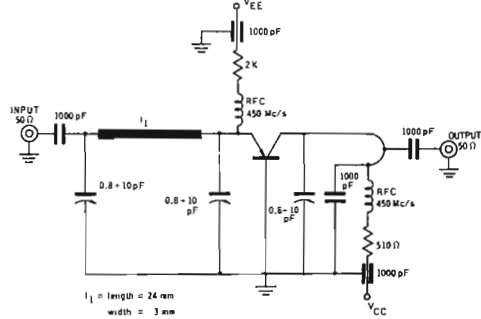
DC PULSE CURRENT GAIN VERSUS COLLECTOR CURRENT



DC PULSE CURRENT GAIN VERSUS TEMPERATURE



450 Mc/s POWER GAIN, AGC AND NF TEST CIRCUIT



NOTES:

- (1) These ratings are limiting values above which the serviceability of any individual semiconductor device may be impaired.
- (2) These ratings give a maximum junction temperature of 200°C and junction-to-case thermal resistance of 67°C/watt (derating factor of 1.48 mW/°C); junction-to-ambient thermal resistance of 1000°C/watt (derating factor of 1.0 mW/°C).
- (3) Rating refers to a high-current point where collector-to-emitter voltage is lowest. For more information send for SGN-AR5.
- (4) Pulse Conditions: length=300 µsec; duty cycle = 1%.
- (5) See the 450 Mc/s Power Gain, AGC and NF test circuits.
- (6) f = 450 Mc/s; R_C = 40 Ω.